

Notice of References Cited	Application/Control No. 10/776,184	Applicant(s)/Patent Under Reexamination OHNO ET AL.	
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	B	US-6,291,106	09-2001	Daido et al.	429/306
	C	US-5,002,843	03-1991	Cieslak et al.	429/101
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NON-PATENT DOCUMENTS

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